

AO4422A

N-Channel Enhancement Mode Field Effect Transistor



General Description

The AO4422A uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO4422A is Pb-free (meets ROHS & Sony 259 specifications). AO4422AL is a Green Product ordering option. AO4422A and AO4422AL are electrically identical.

Features

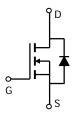
 $V_{DS}(V) = 30V$

 $I_D = 11A$ ($V_{GS} = 10V$)

 $R_{DS(ON)}$ < 15m Ω (V_{GS} = 10V)

 $R_{DS(ON)}$ < 24m Ω (V_{GS} = 4.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V_{DS}	30	V			
Gate-Source Voltage		V_{GS}	±20	V			
Continuous Drain	T _A =25°C		11				
Current ^A	T _A =70°C	I _D	9.3	A			
Pulsed Drain Current ^B		I _{DM}	50				
	T _A =25°C	В	3	14/			
Power Dissipation	T _A =70°C	$-P_{D}$	2.1	W			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	В	31	40	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	$R_{ hetaJA}$	59	75	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{ heta JL}$	16	24	_°C/W			



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS										
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			0.003	1	_			
			T _J =55°C			5	μΑ			
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		1	1.7	3	V			
$I_{D(ON)}$	On state drain current	V _{GS} =4.5V, V _{DS} =5V		30			Α			
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_{D} =11A			11.7	15	m()			
			T _J =125°C		18	22	mΩ			
		V_{GS} =4.5V, I_D =9A			18	24	mΩ			
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =11A			19		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.76	1	V			
I_S	Maximum Body-Diode Continuous Current					4.5	Α			
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			955	1200	pF			
Coss	Output Capacitance				145		pF			
C _{rss}	Reverse Transfer Capacitance				112		pF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			0.5	0.85	Ω			
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge	-V _{GS} =10V, V _{DS} =15V, I _D =11A			17	24	nC			
Q _g (4.5V)	Total Gate Charge				9	12	nC			
Q_{gs}	Gate Source Charge				3.4		nC			
Q_{gd}	Gate Drain Charge				4.7		nC			
t _{D(on)}	Turn-On DelayTime				5	6.5	ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.35 Ω , R_{GEN} =3 Ω			6	7.5	ns			
$t_{D(off)}$	Turn-Off DelayTime				19	25	ns			
t _f	Turn-Off Fall Time				4.5	6	ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =11A, dl/dt=100A/μs			19	21	ns			
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =11A, dI/dt=100A/μs			9	12	nC			

A: The value of R $_{0.JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The value in any a given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

Rev 0 : July 2005

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.



B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_{\rm A}$ =25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

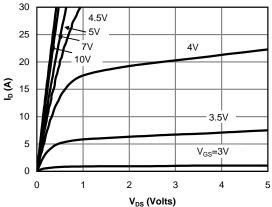


Fig 1: On-Region Characteristics

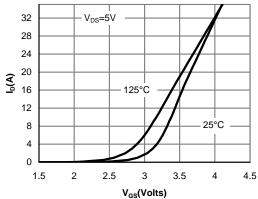


Figure 2: Transfer Characteristics

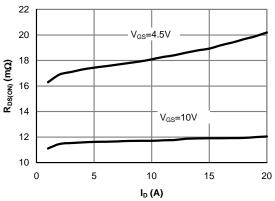


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

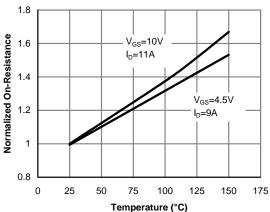


Figure 4: On-Resistance vs. Junction Temperature

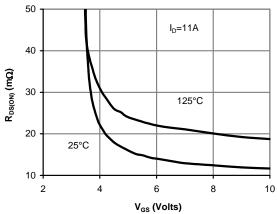


Figure 5: On-Resistance vs. Gate-Source Voltage

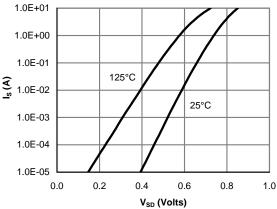
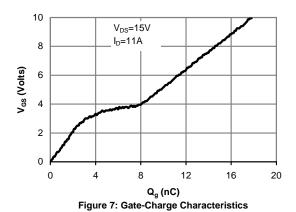


Figure 6: Body-Diode Characteristics



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



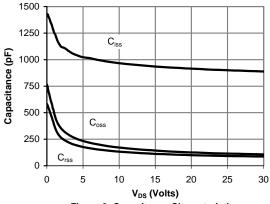


Figure 8: Capacitance Characteristics

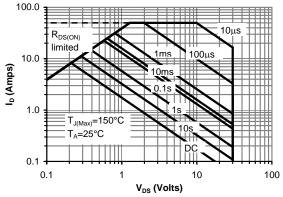


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

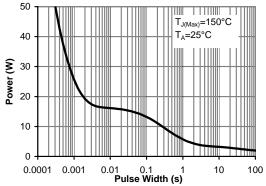


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

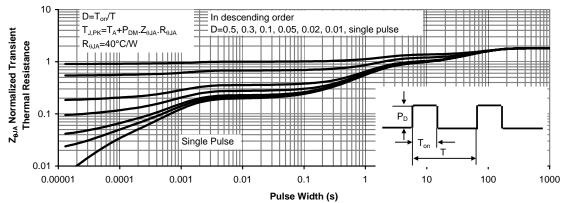


Figure 11: Normalized Maximum Transient Thermal Impedance

